

**Search Notes**

Application/Control No.

10/617,690

Examiner

Jack Chiang

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

2642

**SEARCHED**

Class	Subclass	Date	Examiner
379	433.13	8/11/2005	
455	575.3		
455	575.1		
348	340		
	<i>updated in above</i>	<i>OSmerob</i>	<i>un</i>

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR